

**Product Features**

- PI74AVC+16841 is designed for low-voltage operation,  $V_{CC} = 1.65V$  to  $3.6V$
- True  $\pm 24mA$  Balanced Drive @  $3.3V$
- $I_{OFF}$  supports partial power-down operation
- $3.6V$  I/O Tolerant Inputs and Outputs
- All outputs contain a patented DDC (Dynamic DriveControl) circuit that reduces noise without degrading propagation delay.
- Industrial operation:  $-40^{\circ}C$  to  $+85^{\circ}C$
- Available Packages:
  - 56-pin 240 mil wide plastic TSSOP (A)
  - 56-pin 173 mil wide plastic TVSOP (K)

**Product Description**

Pericom Semiconductor's PI74AVC+ series of logic circuits are produced using the Company's advanced submicron CMOS technology, achieving industry leading speed.

The PI74AVC+16841, a 20-bit bus-interface D-type latch, is designed for  $1.65V$  to  $3.6V$   $V_{CC}$  operation.

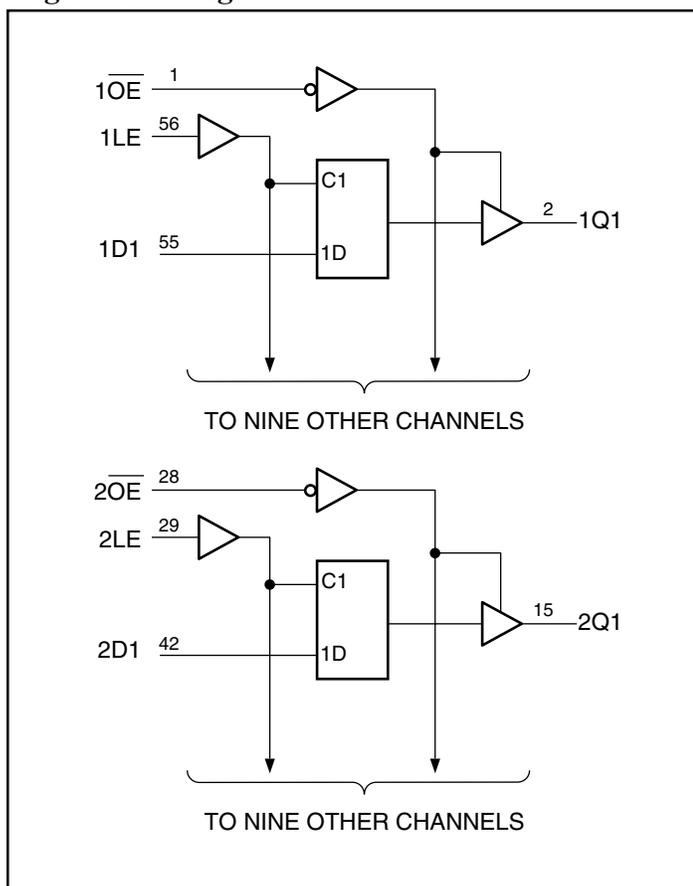
The device features 3-state outputs designed specifically for driving highly capacitive or relatively low-impedance loads. It is particularly suitable for implementing buffer registers, unidirectional bus drivers, and working registers.

The device can be used as two 10-bit latches or one 20-bit latch (transparent D-type). The device has noninverting Data (D) inputs and provides true data at its outputs. While the Latch Enable (1LE or 2LE) input is HIGH, the Q outputs of the corresponding 10-bit latch follow the D inputs. When LE is taken LOW, the Q outputs are latched at the levels set up at the D inputs.

A buffered Output Enable ( $\overline{1OE}$  or  $\overline{2OE}$ ) input can be used to place the outputs of the corresponding 10-bit latch in either a normal logic state (high or low logic levels) or a high-impedance state. In that state, outputs neither load nor drive the bus lines significantly.

The Output Enable ( $\overline{OE}$ ) input does not affect the internal operation of the latches. Old data can be retained or new data can be entered while the outputs are in the high-impedance state.

To ensure the high-impedance state during power up or power down,  $\overline{OE}$  should be tied to  $V_{CC}$  through a pullup resistor; the minimum value of the resistor is determined by the current-sinking capability of the driver.

**Logic Block Diagram**


**Product Pin Description**

Pin Name	Description
$\overline{OE}$	Output Enable Input (Active LOW)
LE	Latch Enable
D	Data Input
Q	Data Output
GND	Ground
VCC	Power

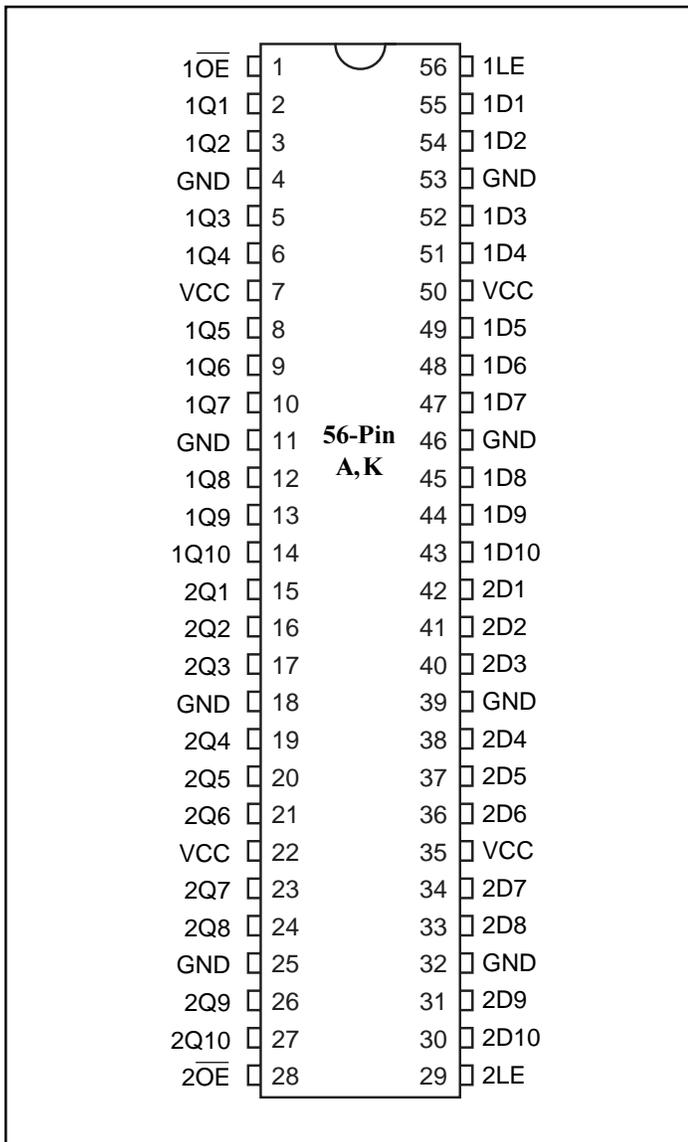
**Truth Table<sup>(1)</sup> Each 10-Bit Latch**

Inputs			Outputs
$\overline{OE}$	LE	D	Q
L	H	H	H
L	H	L	L
L	L	X	Q <sub>O</sub>
H	X	X	Z

**Note:**

- 1. H= High Signal Level
- L= Low Signal Level
- Z= High Impedance
- X= Irrelevant

**Product Pin Configuration**





**Maximum Ratings**

(Above which useful life may be impaired. For user guidelines, not tested.)

Supply voltage range, $V_{CC}$ .....	-0.5V to +4.6V
Input voltage range, $V_I$ .....	-0.5V to +4.6V
Voltage range applied to any output in the high-impedance or power-off state, $V_O^{(1)}$ .....	-0.5V to +4.6V
Voltage range applied to any output in the high or low state, $V_O^{(1,2)}$ .....	-0.5V to $V_{CC}+0.5V$
Input clamp current, $I_{IK}$ ( $V_I < 0$ ) .....	-50mA
Output clamp current, $I_{OK}$ ( $V_O < 0$ ) .....	-50mA
Continuous output current, $I_O$ .....	$\pm 50mA$
Continuous current through each $V_{CC}$ or GND .....	$\pm 100mA$
Package thermal impedance, $\theta_{JA}^{(3)}$ : package A .....	64°C/W
package K .....	48°C/W
Storage Temperature range, $T_{stg}$ .....	-65°C to 150°C

**Note:**

Stresses greater than those listed under MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

**Notes:**

1. Input & output negative-voltage ratings may be exceeded if the input and output current rating are observed.
2. Output positive-voltage rating may be exceeded up to 4.6V maximum if the output current rating is observed.
3. The package thermal impedance is calculated in accordance with JESD 51.

**Recommended Operating Conditions<sup>(1)</sup>**

		Min.	Max.	Units
$V_{CC}$ Supply Voltage	Operating	1.65	3.6	V
	Data retention only	1.2		
$V_{IH}$ High-level Input Voltage	$V_{CC} = 1.2V$	$V_{CC}$		
	$V_{CC} = 1.65V$ to 1.95V	$0.65 \times V_{CC}$		
	$V_{CC} = 2.3V$ to 2.7V	1.7		
	$V_{CC} = 3V$ to 3.6V	2		
$V_{IL}$ Low-level Input Voltage	$V_{CC} = 1.2V$		GND	
	$V_{CC} = 1.65V$ to 1.95V		$0.35 \times V_{CC}$	
	$V_{CC} = 2.3V$ to 2.7V		0.7	
	$V_{CC} = 3V$ to 3.6V		0.8	
$V_I$ Input Voltage		0	3.6	
$V_O$ Output Voltage	Active State	0	$V_{CC}$	
	3-State	0	3.6	
$I_{OH}$ High-level output current	$V_{CC} = 1.65V$ to 1.95V		-6	mA
	$V_{CC} = 2.3V$ to 2.7V		-12	
	$V_{CC} = 3V$ to 3.6V		-24	
$I_{OL}$ Low-level output current	$V_{CC} = 1.65V$ to 1.95V		6	
	$V_{CC} = 2.3V$ to 2.7V		12	
	$V_{CC} = 3V$ to 3.6V		24	
DtDv Input transition rise or fall rate	$V_{CC} = 1.65V$ to 3.6V		5	ns/V
$T_A$ Operating free-air temperature		-40	85	°C

**Notes:**

1. All unused inputs must be held at  $V_{CC}$  or GND to ensure proper device operation.

**DC Electrical Characteristics** (Over the Operating Range,  $T_A = -40^\circ\text{C} + 85^\circ\text{C}$ )

Parameters		Test Conditions <sup>(1)</sup>	$V_{CC}$	Min.	Max.	Units
$V_{OH}$		$I_{OH} = -100\mu\text{A}$	1.65V to 3.6V	$V_{CC} - 0.2\text{V}$		V
		$I_{OH} = -6\text{mA}$ $V_{IH} = 1.07\text{V}$	1.65V	1.2		
		$I_{OH} = -12\text{mA}$ $V_{IH} = 1.7\text{V}$	2.3V	1.75		
		$I_{OH} = -24\text{mA}$ $V_{IH} = 2\text{V}$	3V	2.0		
$V_{OL}$		$I_{OL} = 100\mu\text{A}$	1.65V to 3.6V		0.2	V
		$I_{OL} = 6\text{mA}$ $V_{IH} = 0.57\text{V}$	1.65V		0.45	
		$I_{OL} = 12\text{mA}$ $V_{IH} = 0.7\text{V}$	2.3V		0.55	
		$I_{OL} = 24\text{mA}$ $V_{IH} = 0.8\text{V}$	3V		0.8	
$I_I$		$V_I = V_{CC}$ or GND	3.6V		$\pm 2.5$	$\mu\text{A}$
$I_{OFF}$		$V_I$ or $V_O = 3.6\text{V}$	0		$\pm 10$	
$I_{OZ}$		$V_I = V_{CC}$ or GND	3.6V		$\pm 10$	
$I_{CC}$		$V_O = V_{CC}$ or GND $I_O = 0$	3.6V		40	
$C_I$	Control Inputs	$V_I = V_{CC}$ or GND	2.5V		4	pF
			3.3V		4	
	Data Inputs		2.5V		6	
			3.3V		6	
$C_O$	Outputs	$V_O = V_{CC}$ or GND	2.5V		8	
			3.3V		8	

**Note:**

1. Typical values are measured at  $T_A = 25^\circ\text{C}$ .

### Timing requirements

(Over recommended operating free-air temperature range, unless otherwise noted, see Figures 1 thru 4)

	V <sub>CC</sub> = 1.2V		V <sub>CC</sub> = 1.5V ± 0.1V		V <sub>CC</sub> = 1.8V ± 0.15V		V <sub>CC</sub> = 2.5V ± 0.2V		V <sub>CC</sub> = 3.3V ± 0.3V		Units
	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.	
t <sub>w</sub> Pulse duration, LE HIGH					2.2		2.0		1.8		ns
t <sub>su</sub> Setup time, data before LE↓	1.7		1.2		1.1		0.9		0.8		
t <sub>h</sub> Hold time, data after LE↓	2		1.1		1.1		1.1		0.9		

### Switching Characteristics

(Over recommended operating free-air temperature range, unless otherwise noted, see Figures 1 thru 4)

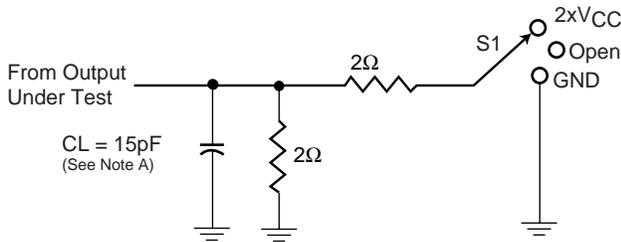
Parameters	From (Input)	To (Output)	V <sub>CC</sub> = 1.2V		V <sub>CC</sub> = 1.5V ± 0.1V		V <sub>CC</sub> = 1.8V ± 0.15V		V <sub>CC</sub> = 2.5V ± 0.2V		V <sub>CC</sub> = 3.3V ± 0.3V		Units
			Typ.	Min.	Max.	Min.	Max.	Min.	Max.	Min.	Max.		
t <sub>pd</sub>	D	Q	6.0	1.2	4.6	1	4.0	0.8	3.1	0.7	2.6	ns	
	LE		7.0	1.4	4.8	1.1	4.0	0.8	3.0	0.7	2.8		
t <sub>en</sub>	OE	Q	6.0	1.6	4.2	1.6	4.0	1.4	3.5	0.7	3.1		
t <sub>dis</sub>	OE	Q	6.0	2.5	5.8	2.3	5.5	1.3	3.4	1.2	3.4		

### Operating Characteristics, T<sub>A</sub>=25°C

Parameters		Test Conditions	V <sub>CC</sub> = 1.8V ±0.15V	V <sub>CC</sub> = 2.5V ±0.2V	V <sub>CC</sub> = 3.3V ±0.3V	Units
			Typical	Typical	Typical	
C <sub>pd</sub> Power Dissipation Capacitance	Outputs Enabled	C <sub>L</sub> = 0pF, f = 10 MHz	50	53	59	pF
	Outputs Disabled		25	28	30	

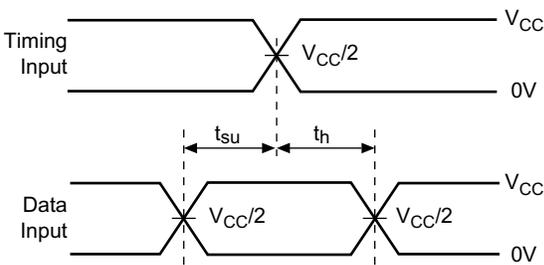
PARAMETER MEASUREMENT INFORMATION

$V_{CC} = 1.2V$  and  $1.5V \pm 0.1V$

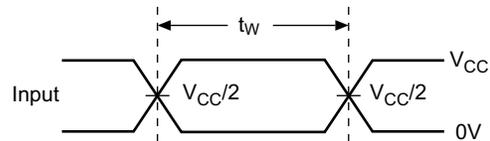


Load Circuit

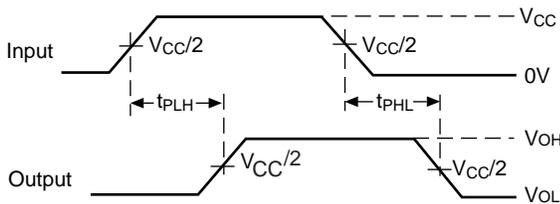
Test	S1
$t_{pd}$ $t_{PLZ}/t_{PZL}$ $t_{PHZ}/t_{PZH}$	Open $2 \times V_{CC}$ GND



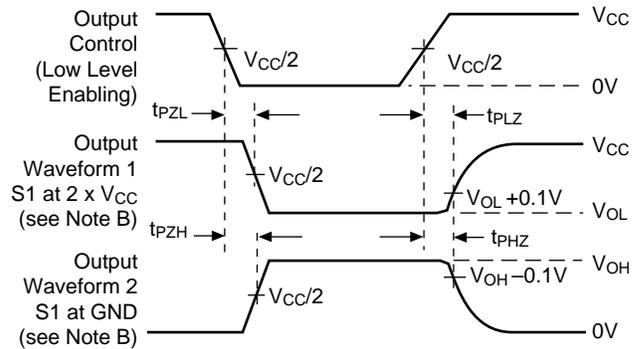
Voltage Waveforms  
Setup and Hold Times



Voltage Waveforms  
Pulse Duration



Voltage Waveforms  
Propagation Delay Times



Voltage Waveforms  
Enable and Disable Times

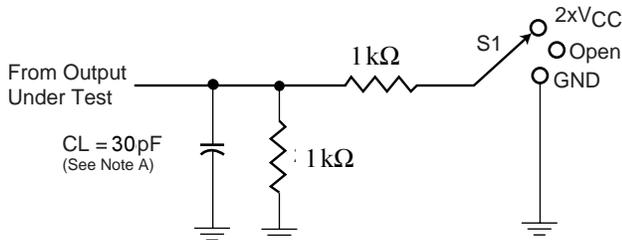
Figure 1. Load Circuit and Voltage Waveforms

Notes:

- A.  $C_L$  includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control.  
Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input impulses are supplied by generators having the following characteristics:  $PRR \leq 10$  MHz,  $Z_O = 50\Omega$ ,  $t_R \leq 2.0ns$ ,  $t_F \leq 2.0ns$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$

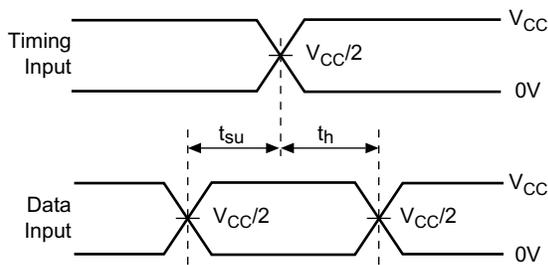
**PARAMETER MEASUREMENT INFORMATION**

$V_{CC} = 1.8V \pm 0.15V$

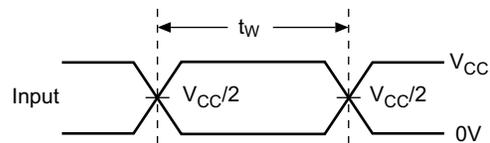


**Load Circuit**

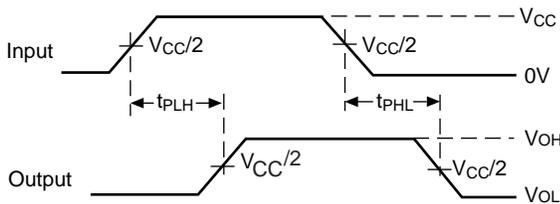
Test	S1
$t_{pd}$ $t_{PLZ}/t_{PZL}$ $t_{PHZ}/t_{PZH}$	Open $2 \times V_{CC}$ GND



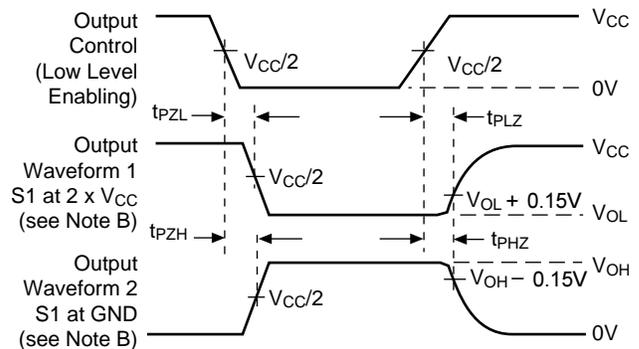
**Voltage Waveforms  
Setup and Hold Times**



**Voltage Waveforms  
Pulse Duration**



**Voltage Waveforms  
Propagation Delay Times**



**Voltage Waveforms  
Enable and Disable Times**

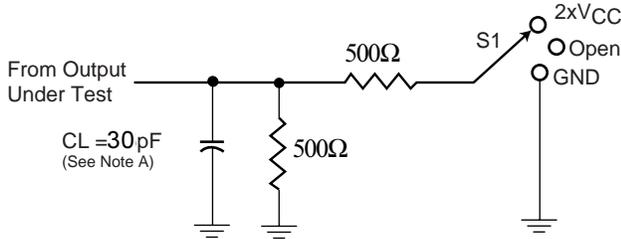
**Figure 2. Load Circuit and Voltage Waveforms**

**Notes:**

- A.  $C_L$  includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input impulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50\Omega$ ,  $t_R \leq 2.0\text{ns}$ ,  $t_F \leq 2.0\text{ns}$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$

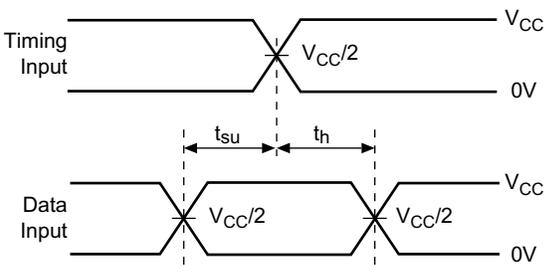
**PARAMETER MEASUREMENT INFORMATION**

$V_{CC} = 2.5V \pm 0.2V$

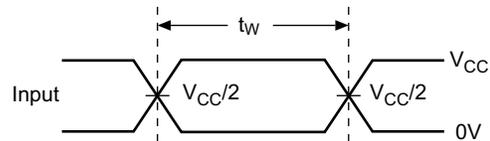


**Load Circuit**

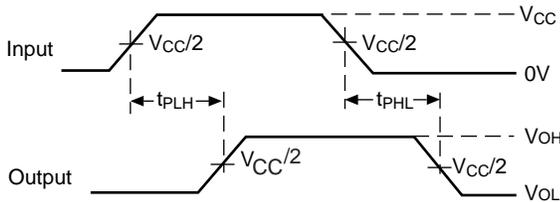
Test	S1
$t_{pd}$ $t_{PLZ}/t_{PZL}$ $t_{PHZ}/t_{PZH}$	Open $2 \times V_{CC}$ GND



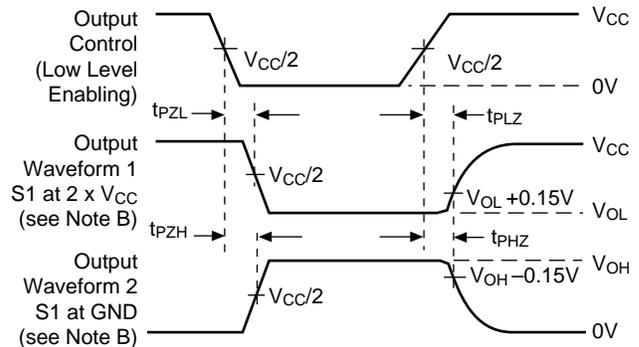
**Voltage Waveforms  
Setup and Hold Times**



**Voltage Waveforms  
Pulse Duration**



**Voltage Waveforms  
Propagation Delay Times**



**Voltage Waveforms  
Enable and Disable Times**

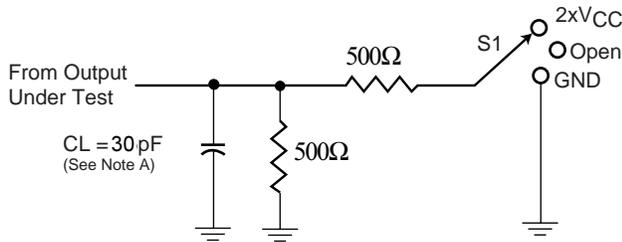
**Figure 3. Load Circuit and Voltage Waveforms**

**Notes:**

- A.  $C_L$  includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input impulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50\Omega$ ,  $t_R \leq 2.0\text{ns}$ ,  $t_F \leq 2.0\text{ns}$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$

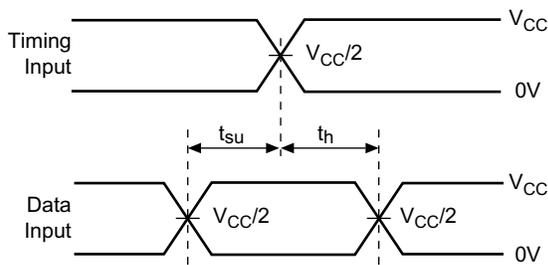
**PARAMETER MEASUREMENT INFORMATION**

$V_{CC} = 3.3V \pm 0.3V$

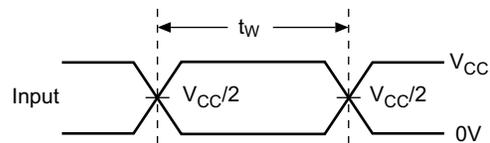


**Load Circuit**

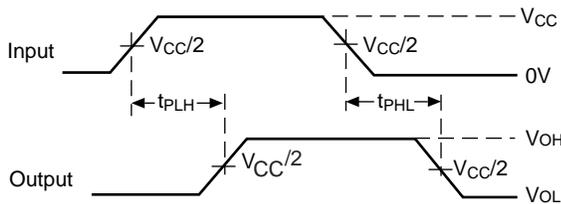
Test	S1
$t_{pd}$ $t_{PLZ}/t_{PZL}$ $t_{PHZ}/t_{PZH}$	Open $2 \times V_{CC}$ GND



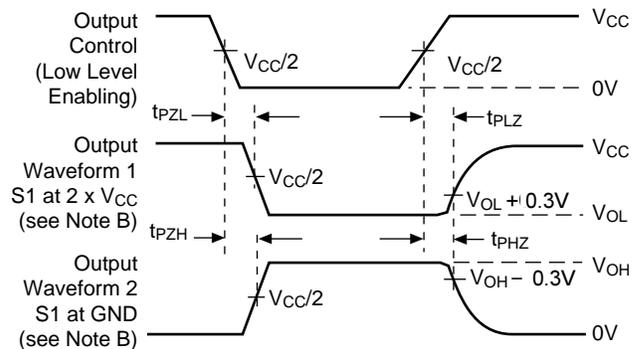
**Voltage Waveforms  
Setup and Hold Times**



**Voltage Waveforms  
Pulse Duration**



**Voltage Waveforms  
Propagation Delay Times**



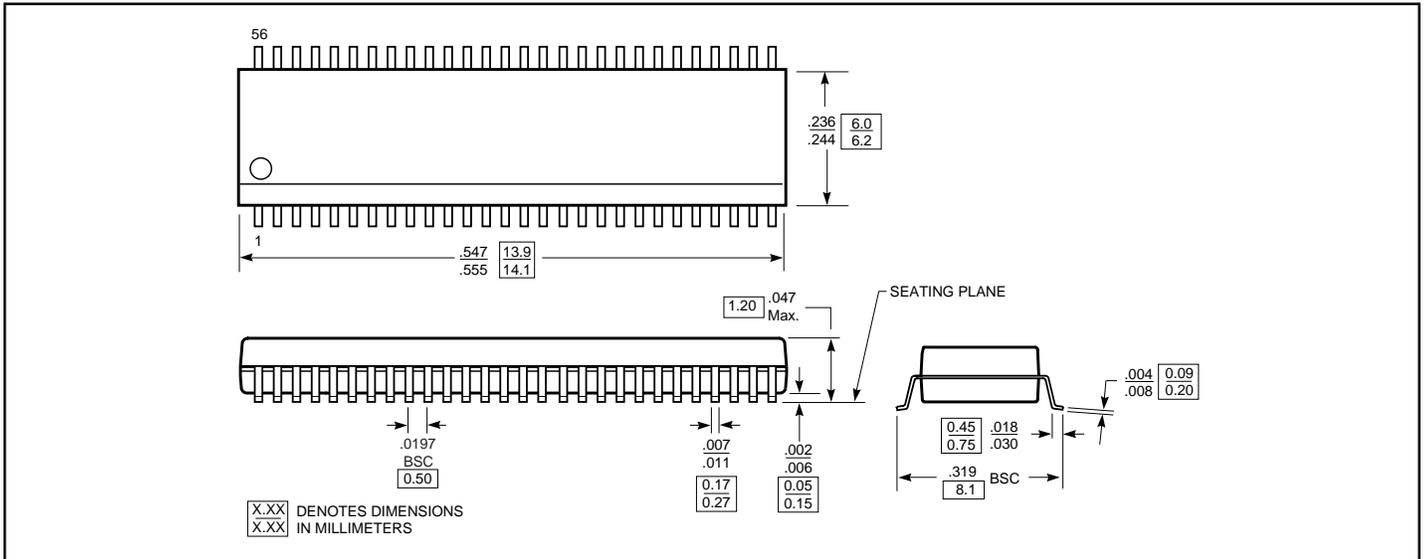
**Voltage Waveforms  
Enable and Disable Times**

**Figure 4. Load Circuit and Voltage Waveforms**

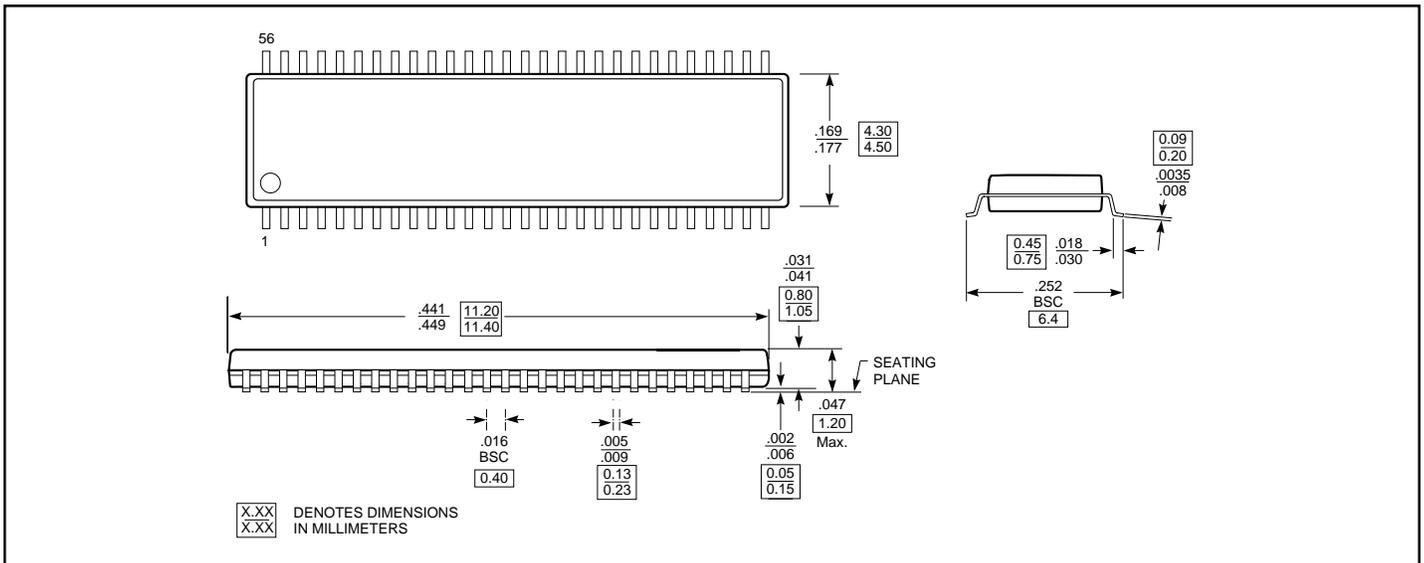
**Notes:**

- A.  $C_L$  includes probe and jig capacitance.
- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input impulses are supplied by generators having the following characteristics:  $PRR \leq 10 \text{ MHz}$ ,  $Z_O = 50\Omega$ ,  $t_R \leq 2.0\text{ns}$ ,  $t_F \leq 2.0\text{ns}$ .
- D. The outputs are measured one at a time with one transition per measurement.
- E.  $t_{PLZ}$  and  $t_{PHZ}$  are the same as  $t_{dis}$
- F.  $t_{PZL}$  and  $t_{PZH}$  are the same as  $t_{en}$
- G.  $t_{PLH}$  and  $t_{PHL}$  are the same as  $t_{pd}$

### 56-pin TSSOP (A) Package



### 56-pin TVSOP (K) Package



### Ordering Information

Ordering Data	Description
PI74AVC+16841A	56-pin, 240-mil wide plastic TSSOP
PI74AVC+16841K	56-pin, 173-mil wide plastic TVSOP